

Switch-mode Series NPN Silicon Power Transistor

BUV22

This device is designed for high speed, high current, high power applications.

Features

• High DC Current Gain:

 h_{FE} min = 20 at I_C = 10 A

• Low V_{CE(sat)}, V_{CE(sat)}

max = 1.0 V at $I_C = 10 \text{ A}$

• Very Fast Switching Times:

TF max = $0.35 \mu s$ at $I_C = 20 A$

• Pb-Free Package is Available*

MAXIMUM RATINGS

Symbol	Rating	Value	Unit
V _{CEO(SUS)}	Collector-Emitter Voltage	250	Vdc
V _{CBO}	Collector-Base Voltage	300	Vdc
V _{EBO}	Emitter-Base Voltage	7	Vdc
V _{CEX}	Collector–Emitter Voltage (V _{BE} = -1.5 V)	300	Vdc
V _{CER}	Collector–Emitter Voltage ($R_{BE} = 100 \Omega$)	290	Vdc
I _C			Adc Apk
Ι _Β	Base-Current Continuous	8	Adc
P _D	P _D Total Device Dissipation @ T _C = 25°C		W
T _J , T _{stg} Operating and Storage Junction Temperature Range		-65 to 200	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Characteristics	Max	Unit
$\theta_{\sf JC}$	Thermal Resistance, Junction-to-Case	0.7	°C/W

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40 AMPERES NPN SILICON POWER METAL TRANSISTOR 250 VOLTS - 250 WATTS



TO-204AE (TO-3) **CASE 197A**

MARKING DIAGRAM



BUV22 = Device Code = Pb-Free Package = Assembly Location

= Year WW = Work Week = Country of Origin

ORDERING INFORMATION

Device	Package	Shipping
BUV22G	TO-204 (Pb-Free)	100 Units / Tray

DISCONTINUED (Note 1)

	, ,	
BUV22	TO-204	100 Units / Tray

DISCONTINUED: This device is not recommended for new design. Please contact your onsemi representative for information. The most current information on this device may be available on www.onsemi.com.

^{*}For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

BUV22

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

Symbol		Min	Max	Unit	
OFF CHARA	CTERISTICS (Note 2)				
V _{CEO(sus)}	Collector–Emitter Sustaining Vo	250	-	Vdc	
I _{CEX}	Collector Cutoff Current at Rev $(V_{CE} = 300 \text{ V}, V_{BE} = -1.5 \text{ V})$ $(V_{CE} = 300 \text{ V}, V_{BE} = -1.5 \text{ V}, V_{CE} = -1.5 \text{ V})$		3.0 12.0	mAdc	
I _{CEO}	Collector–Emitter Cutoff Currer (V _{CE} = 200 V)	-	3.0	mAdc	
V_{EBO}	Emitter-Base Reverse Voltage (I _E = 50 mA)	7	-	V	
I _{EBO}	Emitter-Cutoff Current (V _{EB} = 5 V)	-	1.0	mAdc	
SECOND BR	EAKDOWN				
I _{S/b}	Second Breakdown Collector Current with base forward biased ($V_{CE} = 20 \text{ V}, t = 1 \text{ s}$) ($V_{CE} = 140 \text{ V}, t = 1 \text{ s}$)		12 0.15		Adc
ON CHARAC	TERISTICS (Note 2)			•	•
h _{FE}	DC Current Gain (I _C = 10 A, V _{CE} = 4 V) (I _C = 20 A, V _{CE} = 4 V)		20 10	60	
V _{CE(sat)}	Collector–Emitter Saturation Voltage $(I_C = 10 \text{ A}, I_B = 1 \text{ A})$ $(I_C = 20 \text{ A}, I_B = 2.5 \text{ A})$			1.0 1.5	Vdc
V _{BE(sat)}	Base–Emitter Saturation Voltage (I _C = 40 A, I _B = 4 A)			1.5	Vdc
DYNAMIC CH	HARACTERISTICS		<u>.</u>	_	
f _T	Current Gain — Bandwidth Product $(V_{CE} = 15 \text{ V, } I_{C} = 2 \text{ A, } f = 4 \text{ MHz})$		8.0		MHz
SWITCHING	CHARACTERISTICS (Resistive L	oad)	-		
t _{on}	Turn-on Time			0.8	μs
t _s	Storage Time	$(I_C = 20 \text{ A}, I_{B1} = I_{B2} = 2.5 \text{ A},$ $V_{CC} = 100 \text{ V}, R_C = 5 \Omega)$		2.0	1
t _f	Fall Time	100 100 1,110 0 111		0.35	1

^{2.} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.

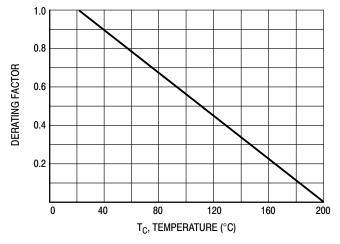


Figure 1. Power Derating

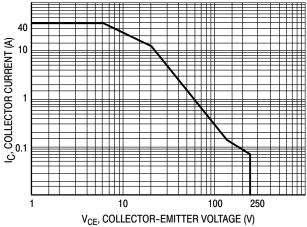


Figure 2. Active Region Safe Operating Area

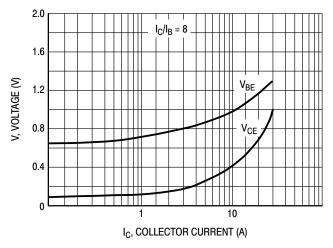


Figure 3. "On" Voltages

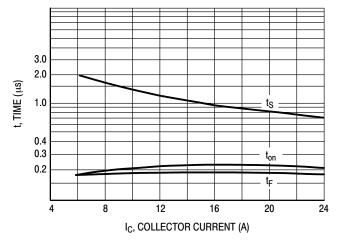


Figure 5. Resistive Switching Performance

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C – V_{CE} limits of the transistor that must be observed for reliable operation i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 2 is based on $T_C = 25^{\circ}C$; $T_{J(pk)}$ is variable depending on power level. Second breakdown limitations do not derate the same as thermal limitations.

At high case temperatures, thermal limitations will reduce the power that can handled to values less than the limitations imposed by second breakdown.

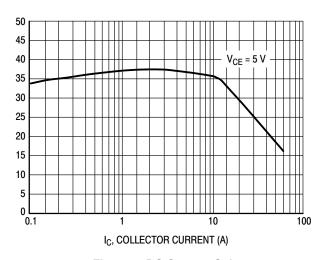
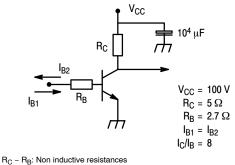


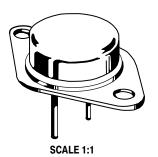
Figure 4. DC Current Gain



..С ..В.....

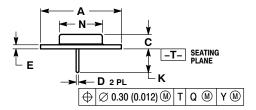
Figure 6. Switching Times Test Circuit

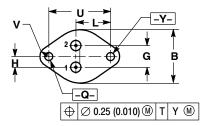




TO-204 (TO-3) CASE 197A-05 ISSUE K

DATE 21 FEB 2000





STYLE 1: PIN 1. BASE 2. EMITTER CASE: COLLECTOR STYLE 2: PIN 1. EMITTER 2. BASE CASE: COLLECTOR

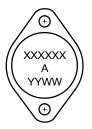
STYLE 3: PIN 1. GATE 2. SOURCE CASE: DRAIN

STYLE 4: PIN 1. ANODE = 1 2. ANODE = 2 CASE: CATHODES

- 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETER	
DIM	MIN	MAX	MIN	MAX
Α	1.530 REF		38.86 REF	
В	0.990	1.050	25.15	26.67
С	0.250	0.335	6.35	8.51
D	0.057	0.063	1.45	1.60
Е	0.060	0.070	1.53	1.77
G	0.430 BSC		10.92 BSC	
Н	0.215 BSC		5.46 BSC	
Κ	0.440	0.480	11.18	12.19
L	0.665 BSC		16.89 BSC	
N	0.760	0.830	19.31	21.08
Q	0.151	0.165	3.84	4.19
U	1.187 BSC		30.15 BSC	
V	0.131	0.188	3.33	4 77

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code Α = Assembly Locationa

YY = Year WW = Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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